Determination of crystal structures by X-ray diffraction

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- The geometrical structure factor
- 4 The atomic form factor

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Bragg and Von Laue formulation of X-ray diffraction by a crystal

2 Experimental geometries suggested by the Laue condition

3 The geometrical structure factor

4 The atomic form factor

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Diffraction by a crystal

The electromagnetic probe

X-ray diffraction

- Interatomic distances are of the order of Å
 - 10⁻⁸cm
 - $E = \hbar \omega = rac{\hbar c}{\lambda} \sim 12.3 imes 10^3 \ {
 m eV}$
- Wavelength and energies characteristic of X-rays
- Sharp peaks of scattered radiation
 - due to long range order
 - not found for amorphous solids or liquids



Diffraction by a crystal

The electromagnetic probe

X-ray diffraction

- We consider a rigid lattice of ions
- Effect of vibrations:
 - decrease the intensity of the scattered peaks
 - contribute to the diffuse background



X-ray diffraction pattern from a crystal

Diffraction by a crystal

X-ray diffraction

Equivalent Formulations

- Bragg formulation
 - used by crystallographers
- Von Laue formulation
 - exploits the reciprocal lattice
 - closer to the solid-state approach



X-ray diffraction pattern from a crystal

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X-ray diffraction by a crystal Bragg formulation

Bragg's interpretation of X-ray diffraction

- Crystal composed of parallel planes (lattice planes)
 - separated by a distance d
- Conditions for the appearance of sharp diffraction peaks
 - X-rays are specularly reflected by the crystal planes
 - constructive interference of reflected X-rays
- Bragg's condition: $n\lambda = 2d \sin \theta$
 - *n* : order of reflection
 - θ : angle of incidence on the crystal's plane

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Bragg interpretation of X-ray diffraction

Simple derivation of Bragg condition

- Condition for constructive interference:
 - path difference $(2d \sin \theta)$ equals an integral number of wavelengths
 - total angle of deflection of the incident rays: 2θ



Bragg's interpretation of X-ray diffraction

Further observations

- A large number of reflections arise as a result of
 - different wavelengths of incident X-rays
 - different reflection orders *n* for a given set of planes
 - different set of lattice planes (infinitely many)





Two possible resolutions of the same crystal lattice into planes

Von Laue formulation

Assumptions

- Crystal composed of scatterers at the sites \boldsymbol{R} of a Bravais lattice
 - atoms, ions
- Peaks are observed for directions of constructive interference between all scattered rays
- no resolution of the lattice into crystal planes
- no need to assume specular reflection



two scattering centers separated by a displacement vector \boldsymbol{d}

Von Laue formulation

Derivation of the condition of constructive interference

- Wave vector of incident radiation: $\boldsymbol{k} = \frac{2\pi}{\lambda} \hat{\boldsymbol{n}}$
- Wave vector of scattered radiation: ${m k}'={2\pi\over\lambda}{\hat{m n}}'$
 - elastic scattering
- Path difference: $\boldsymbol{d} \cdot (\hat{\boldsymbol{n}} \hat{\boldsymbol{n}}')$

•
$$\boldsymbol{d} \cdot (\boldsymbol{k} - \boldsymbol{k}') = 2\pi m \ (m \text{ integer})$$



two scattering centers separated by a displacement vector \boldsymbol{d}

Von Laue formulation

Derivation of the condition of constructive interference

- For all scatteres in the lattice: $\boldsymbol{R} \cdot (\boldsymbol{k} \boldsymbol{k}') = 2\pi m, \forall \boldsymbol{R}$
 - all scattered rays interfere constructively
- Alternatively: $e^{i(k'-k)\cdot R} = 1$
 - $\mathbf{k} \mathbf{k}'$ is a reciprocal lattice vector \mathbf{K}



two scattering centers separated by a displacement vector \boldsymbol{d}

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Von Laue formulation

Another geometrical interpretation

- $\mathbf{k} \mathbf{k}'$ is a reciprocal lattice vector \mathbf{K}
- $k = |\mathbf{k} \mathbf{K}|$ and squaring

•
$$\boldsymbol{k} \cdot \hat{\boldsymbol{K}} = \frac{1}{2}\boldsymbol{K}$$

• component of k along K



k-space plane (Bragg plane)

Equivalence of Bragg and Von Laue formulations

Proof

- Von Laue condition: $\mathbf{k}' \mathbf{k} = \mathbf{K} \ (k' = k)$
- K is \perp to a family of direct lattice planes



K bisects the angle between **k** and \mathbf{k}'

Equivalence of Bragg and Von Laue formulations

Proof

- if *d* distance between planes, $|\mathbf{K}| = 2k \sin \theta = n|\mathbf{K}_0| = n \frac{2\pi}{d}$
- $k \sin \theta = \frac{n\pi}{d}$ (Bragg condition)
- Reflection from the lattice planes $\perp \mathbf{K}$
- The order of reflection is $n = \frac{|\mathbf{K}|}{|\mathbf{K}_0|}$



K bisects the angle between \boldsymbol{k} and \boldsymbol{k}'

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Bragg and Von Laue formulation of X-ray diffraction by a crystal

Experimental geometries suggested by the Laue condition

3 The geometrical structure factor



Devising experimental setups

- Laue condition: the tip of k must lie on a Bragg plane
 - k-space plane
- Difficult to realize for fixed orientation and λ
- How do we achieve enough sampling of the reciprocal space?
 - vary the wavelength of X-rays
 - vary the direction of incidence (i.e. relative orientation of the crystal)
- Ewald construction

The Ewald sphere

- Draw a sphere of radius k centered on the tip of k $(k = \frac{2\pi}{\lambda})$
 - passes through the origin
- Diffraction peaks for lattice points on the surface of the sphere
 - **k**' satisfies the Laue condition



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The Laue method

- Use polychromatic X-rays (from λ_1 to λ_0)
 - fixed orientation of the crystal and incident direction \hat{n}

•
$$\boldsymbol{k}_1 = \frac{2\pi}{\lambda_1} \hat{\boldsymbol{n}}, \ \boldsymbol{k}_0 = \frac{2\pi}{\lambda_0} \hat{\boldsymbol{n}}$$

- Diffracted rays in correspondence to multiple reciprocal lattice points
 - region between the two spheres



the Ewald construction for the Laue method

The rotating-crystal method

- Use monochromatic X-rays of fixed incident direction
- Vary the orientation of the crystal
 - rotation around a fixed axis
 - the reciprocal lattice rotates around the same axis by the same amount



the Ewald construction for the rotating-crystal method

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Experimental geometries suggested by the Laue condition The Debye-Scherrer Method

Powder Method

Rotating-crystal method with rotation axis over all possible directions

- finely dispersed powder (randomly oriented crystals)
- Each *K* generates a sphere of radius *K*
- All K such that K < 2k generates a cone of diffracted radiation
 - $K = 2k \sin \frac{1}{2}\phi$



the Ewald construction for the Debye-Scherrer Method

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The geometrical structure factor



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Diffraction by a monoatomic lattice with a basis

The geometrical structure factor

Several identical scatterers in the primitive cell

- *n* scatterers at positions $\{d_i\}_{i=1,...,n}$
 - *n*-atom basis (e.g. diamond structure: n = 2)
- For a Bragg peak with $\mathbf{K} = \mathbf{k}' \mathbf{k}$
 - constructive/desctructive interference btw scattered rays
 - Phase difference: $\boldsymbol{K} \cdot (\boldsymbol{d}_i \boldsymbol{d}_j)$



path difference btw rays scattered by centers at a distance \boldsymbol{d}

Diffraction by a monoatomic lattice with a basis

The geometrical structure factor

Several identical scatterers in the primitive cell

- The amplitude of the rays will differ by a factor $e^{i \mathbf{K} \cdot (\mathbf{d}_i \mathbf{d}_j)}$
- For the *n* scatterers the amplitudes are in the ratio:

$$e^{i\boldsymbol{K}\cdot\boldsymbol{d}_1}$$
: $e^{i\boldsymbol{K}\cdot\boldsymbol{d}_2}$:... $e^{i\boldsymbol{K}\cdot\boldsymbol{d}_n}$

• The total amplitude of X-ray scattered by the cell contains the factor

$$S_{\boldsymbol{K}} = \sum_{j=1}^{n} e^{i \boldsymbol{K} \cdot \boldsymbol{d}_{j}}$$

- $S_{\mathbf{K}}$: geometrical structure factor
- $I_K \propto |S_K|^2$

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Diffraction by a monoatomic lattice with a basis

The geometrical structure factor

Absolute intensity in a Bragg peak

- The intensity depends on K through S_K
- Not the only source of *K* dependence
 - characteristic angular dependence of the scattering process
 - internal structure of the scatterer
- S_K alone cannot be used to predict the absolute intensity
- When $S_{\boldsymbol{K}} = 0 \Longrightarrow I_{\boldsymbol{K}} = 0$
 - complete destructive interference

Examples

bcc viewed as a sc lattice with a basis

- The reciprocal lattice is fcc
- bcc can be regarded as a sc lattice with a basis
 - primitive vectors: $a\hat{x}$, $a\hat{y}$, $a\hat{z}$

• basis:
$$d_1 = 0$$
, $d_2 = (rac{a}{2})(\hat{\pmb{x}} + \hat{\pmb{y}} + \hat{\pmb{z}})$

• K must be a vector of the reciprocal lattice

•
$$K = \frac{2\pi}{a} (n_1 \hat{x} + n_2 \hat{y} + n_3 \hat{z})$$

• $S_K = 1 + e^{i\pi(n_1 + n_2 + n_3)} = 1 + (-1)^{n_1 + n_2 + n_3}$
• $S_K = 2$ when $n_1 + n_2 + n_3$ is even
• $S_K = 0$ when $n_1 + n_2 + n_3$ is odd

Examples

bcc viewed as a sc lattice with a basis

- K vectors for which $S_K = 0$ will have no Bragg reflection
 - odd number of nearest-neighbour bonds
 - from the origin
- K vectors for which $S_K \neq 0$ define a reciprocal fcc lattice

• side of $\frac{4\pi}{a}$



K points for which $S_K = 2$ (black circles) and $S_K = 0$ (white circles)

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Examples

Monoatomic diamond lattice (C, Si, Ge, grey tin)

- Not a Bravais lattice
- Viewed as a fcc lattice with a two-atom basis

•
$$a_1 = \frac{a}{2}(\hat{y} + \hat{z})$$
 etc
• basis: $d_1 = 0$, $d_2 = \frac{a}{4}(\hat{x} + \hat{y} + \hat{z})$

• **K** must be a vector of the **bcc** reciprocal lattice $\mathbf{K} = \sum_{i} n_i \mathbf{b}_i$

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Examples

Monoatomic diamond lattice (C, Si, Ge, grey tin)

•
$$\mathbf{K} = \sum_{i} n_{i} \mathbf{b}_{i} = \frac{4\pi}{a} (\nu_{1} \hat{\mathbf{x}} + \nu_{2} \hat{\mathbf{y}} + \nu_{3} \hat{\mathbf{z}})$$

• $\nu_{j} = \frac{1}{2} (n_{1} + n_{2} + n_{3}) - n_{j}$
• $\sum_{j} \nu_{j} = \frac{1}{2} (n_{1} + n_{2} + n_{3})$

- The bcc is viewed as composed of two sc lattices
- The first contains the origin ($\mathbf{K} = 0$)
 - ν_i are integers $(n_1 + n_2 + n_3 \text{ twice an even/odd})$
 - $S_{\kappa} = 0, 2$ ($S_{\kappa} = 0$ when $\sum_{i} \nu_{i}$ is odd, as before)



 ${m K}$ points for which $S_{{m K}}=2,~S_{{m K}}=1\pm i,$ and $S_{{m K}}=0$ (white circles)

Examples

Monoatomic diamond lattice (C, Si, Ge, grey tin)

•
$$\mathbf{K} = \sum_{i} n_{i} \mathbf{b}_{i} = \frac{4\pi}{a} (\nu_{1} \hat{\mathbf{x}} + \nu_{2} \hat{\mathbf{y}} + \nu_{3} \hat{\mathbf{z}})$$

• $\nu_{j} = \frac{1}{2} (n_{1} + n_{2} + n_{3}) - n_{j}$
• $\sum_{j} \nu_{j} = \frac{1}{2} (n_{1} + n_{2} + n_{3})$

- The bcc is viewed as composed of two sc lattices
- The second contains $\mathbf{K} = \frac{4\pi}{a} \frac{1}{2} (\hat{\mathbf{x}} + \hat{\mathbf{y}} + \hat{\mathbf{z}})$
 - all ν_i must be integer $+\frac{1}{2}(n_1 + n_2 + n_3 \text{ odd})$
 - $S_{\kappa} = 1 \pm i$



 ${\pmb K}$ points for which ${\pmb S}_{{\pmb K}}=2,~{\pmb S}_{{\pmb K}}=1\pm i,$ and ${\pmb S}_{{\pmb K}}=0$ (white circles)

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Image: A matrix

The atomic form factor

Diffraction by a polyatomic crystal

The atomic form factor

Scattering by different centers in the basis

• If the scatterers are not identical

$$S_{\boldsymbol{K}} = \sum_{j=1}^{n} f_j(\boldsymbol{K}) e^{i \boldsymbol{K} \cdot \boldsymbol{d}_j}$$

- $f_j(K)$: atomic form factor
- depends on its internal structure
- identical centers have identical $f_j(\mathbf{K})$
- consistent with previous treatment

The atomic form factor

Diffraction by a polyatomic crystal

The atomic form factor

Scattering by different centers in the basis

• In simple treatments

$$f_j(\boldsymbol{K}) = -\frac{1}{e} \int d\boldsymbol{r} e^{i\boldsymbol{K}\cdot\boldsymbol{r}} \rho_j(\boldsymbol{r})$$

- Fourier transform of $\rho_j(\mathbf{r})$
- $\rho_j(\mathbf{r})$: electronic charge density of ion of type j at $\mathbf{r} = 0$